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ATTORNEY DOCKET No.

9319S-000114

SERIAL No.

09/445,523

APPLICANT

Maeda

FILING DATE

December 7, 1999

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2871

**U.S. PATENT DOCUMENTS**

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.						

**FOREIGN PATENT DOCUMENTS**

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.	DN	JP 06-313890	11/08/94	Japan	—	X	

**OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)**

Ref. Desig.	Examiner's Initials	
1.		<del>Examination Report for Japanese Application No. 2001-330670</del> NOT PRIOR ART

Examiner:

DNQUYEN

Date Considered:

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## FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes No
1.	DN	11-052366	2/26/1999	Japan	—	Abstract

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.		Examination report from corresponding Japanese Application No. 2001-330670- NOT PRIOR ART

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